

UNISONIC TECHNOLOGIES CO., LTD

# 5N50-P

### **Power MOSFET**

# 5A, 500V N-CHANNEL POWER MOSFET

#### DESCRIPTION

The UTC **5N50-P** is an N-channel power MOSFET adopting UTC's advanced technology to provide customers with DMOS, planar stripe technology. This technology is designed to meet the requirements of the minimum on-state resistance and perfect switching performance. It also can withstand high energy pulse in the avalanche and communication mode.

The UTC **5N50-P** can be used in applications, such as active power factor correction, high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.

#### FEATURES

- \*  $R_{DS(ON)}$  < 1.6 $\Omega$  @  $V_{GS}$  = 10 V,  $I_D$  = 2.5 A
- \* 100% avalanche tested
- \* High switching speed

#### SYMBOL





#### ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Decking
Lead Free	Halogen Free	гаскауе	1	2	3	Facking
5N50L-TA3-T	5N50G-TA3-T	TO-220	G	D	S	Tube
5N50L-TF3-T	5N50G-TF3-T	TO-220F	G	D	S	Tube
5N50L-TF1-T	5N50G-TF1-T	TO-220F1	G	D	S	Tube
5N50L-TF2-T	5N50G-TF2-T	TO-220F2	G	D	S	Tube
5N50L-TM3-R	5N50G-TM3-R	TO-251	G	D	S	Tape Reel
5N50L-TMS4-R	5N50G-TMS4-R	TO-251S4	G	D	S	Tape Reel
5N50L-TN3-R	5N50G-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

5N50L-TA2-T (1)Packing Type (2)Package Type (3)Green Package	<ul> <li>(1) R: Tape Reel, T: Tube</li> <li>(2) TA3: TO-220, TF3: TO-220F, TF1: TO-220F1 TF2: TO-220F2, TM3: TO-251, TMS4: TO-251S4 TN3: TO-252</li> <li>(3) L: Lead Free, G: Halogen Free and Lead Free</li> </ul>
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# 5N50-P

# MARKING





#### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V <sub>DSS</sub>	500	
Gate-Source Voltage		V <sub>GSS</sub>	±30 V	
Drain Current	Continuous	Ι <sub>D</sub>	5	А
	Pulsed (Note 2)	I <sub>DM</sub>	20	А
Avalanche Current (Note	e 2)	I <sub>AR</sub>	I <sub>AR</sub> 5	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	190	mJ
	Repetitive (Note 2)	E <sub>AR</sub>	7.3	mJ
Peak Diode Recovery dv	//dt (Note 4)	dv/dt 4.5 V		V/ns
Power Dissipation	TO-220		125	W
	TO-220F/TO-220F1 TO-220F2	P <sub>D</sub>	38	W
	TO-251/TO-251S4 TO-252		54	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T <sub>STG</sub>	-55~+150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 15.5mH,  $I_{AS}$  = 5A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25°C
- 4. I<sub>SD</sub> ≤5A, di/dt ≤ 200A/µs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C

#### THERMAL DATA

PARAN	<b>IETER</b>	SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-220F TO-220F1/TO-220F2	٩	62.5	°C/W
	TO-251/TO-251S4 TO-252	OJA	110	°C/W
Junction to Case	TO-220	θ <sub>JC</sub>	1	°C/W
	TO-220F/TO-220F1 TO-220F2		3.25	°C/W
	TO-251/TO-251S4 TO-252		2.13	°C/W



#### ■ ELECTRICAL CHARACTERISTICS (T<sub>C</sub>=25°C, unless otherwise specified)

		r	1		1	1	
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	I <sub>D</sub> =250μΑ, V <sub>GS</sub> =0V	500			V
Breakdown Voltage Temperature Coefficient		$\bigtriangleup BV_{\text{DSS}} / \bigtriangleup T_{\text{J}}$	Reference to 25°C, I <sub>D</sub> =250µA		0.5		V/°C
Drain Source Lookage Current		Inco	V <sub>DS</sub> =500V, V <sub>GS</sub> =0V			1	
		USS	V <sub>DS</sub> =400V, T <sub>C</sub> =125°C			10	μΑ
Gate- Source Leakage Current	Forward	- I <sub>GSS</sub>	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V			100	nA
	Reverse		V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V <sub>GS(TH)</sub>	$V_{DS}=V_{GS}, I_{D}=250\mu A$			4.0	V
Static Drain-Source On-State Re	esistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2.5A		1.2	1.6	Ω
DYNAMIC PARAMETERS							
Input Capacitance		CISS			580		pF
Output Capacitance		Coss	$V_{GS}=0V, V_{DS}=25V,$		66		pF
Reverse Transfer Capacitance		C <sub>RSS</sub>			10		pF
SWITCHING PARAMETERS		_					
Total Gate Charge		$Q_{G}$	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V,		18	24	nC
Gate to Source Charge		$Q_{GS}$			2.2		nC
Gate to Drain Charge		$Q_{GD}$	$10-1.3A$ , $10-100\mu A$ (Note 1, 2)		9.7		nC
Turn-ON Delay Time		t <sub>D(ON)</sub>			30		ns
Rise Time		t <sub>R</sub>	V <sub>DD</sub> =30V, I <sub>D</sub> =0.5A,		80		ns
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		110		ns
Fall-Time		t⊧			90		ns
SOURCE- DRAIN DIODE RATII	NGS AND CH	HARACTERIS	<b>FICS</b>				
Maximum Continuous Drain-Source Diode		1				5	^
Forward Current		IS				5	A
Maximum Pulsed Drain-Source Diode						20	^
Forward Current		ISM				20	A
Drain-Source Diode Forward Voltage		V <sub>SD</sub>	I <sub>S</sub> =5A, V <sub>GS</sub> =0V			1.4	V
Reverse Recovery Time		t <sub>rr</sub>	I <sub>S</sub> =5A, V <sub>GS</sub> =0V,		263		ns
Reverse Recovery Charge		Q <sub>RR</sub>	dl <sub>F</sub> /dt=100A/µs (Note 1)		1.9		μC

Notes: 1. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2%

2. Essentially independent of operating temperature



### TEST CIRCUITS AND WAVEFORMS



Gate Charge Test Circuit



**Resistive Switching Test Circuit** 



**Unclamped Inductive Switching Test Circuit** 



**Gate Charge Waveforms** 



**Resistive Switching Waveforms** 



**Unclamped Inductive Switching Waveforms** 



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### ■ TEST CIRCUITS AND WAVEFORMS(Cont.)



#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





## TYPICAL CHARACTERISTICS

Drain Current vs. Drain-Source



Drain Current vs. Gate Threshold Voltage

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